Annex 4: Test setup photographs 22-1-0131901T002a-C01 - A4

Number of pages:	6	**Date of Report:**	2023-May-15
Testing company:	CETECOM GmbH Im Teelbruch 116 45219 Essen Germany Tel. + 49 (0) 20 54 / 95 19-0 Fax: + 49 (0) 20 54 / 95 19-150	**Applicant:**	BBC Bircher AG
Product: **Model:**	**Wireless Transmission System** **XRF-T.2**		
FCC ID:	TBZ-XRFT29	**IC:**	5904A-XRFT29
Testing has been carried out in accordance with:	**FCC Regulations** **Title 47 CFR, Chapter I, Subchapter A, Part 15** **Subpart C Intentional Radiators** § 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz **ISED-Regulations** **Radio Standards Specification** **RSS-Gen, Issue 5** General Requirements for Compliance of Radio Apparatus **RSS-247, Issue 2** Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence-Exempt Local Area Network (LE-LAN) Device		

The test results relate only to the individual items which have been tested. This report shall not be reproduced in parts without the written approval of the testing laboratory © Copyright: All rights reserved by CETECOM

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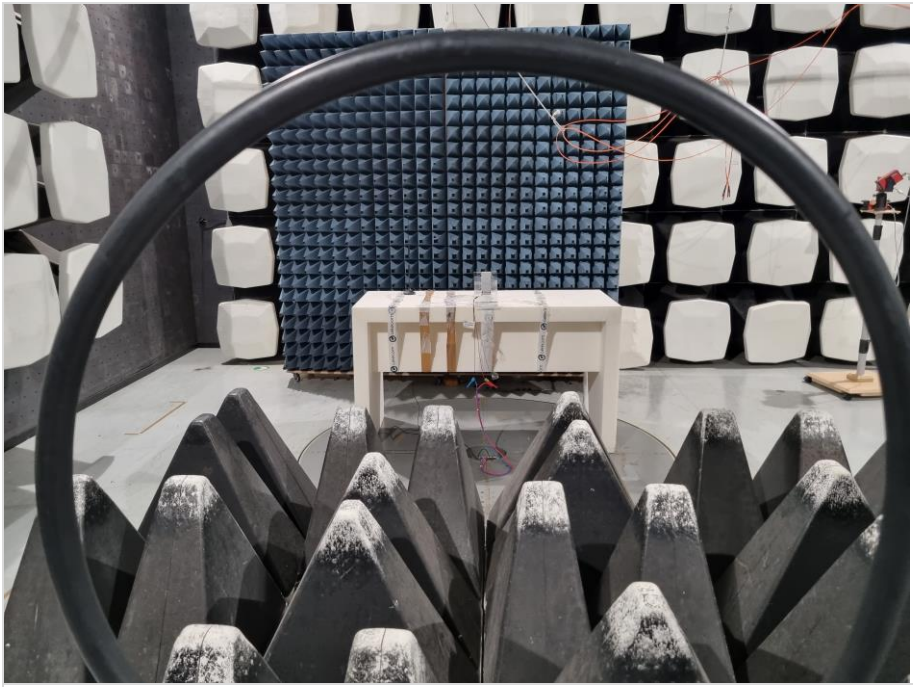
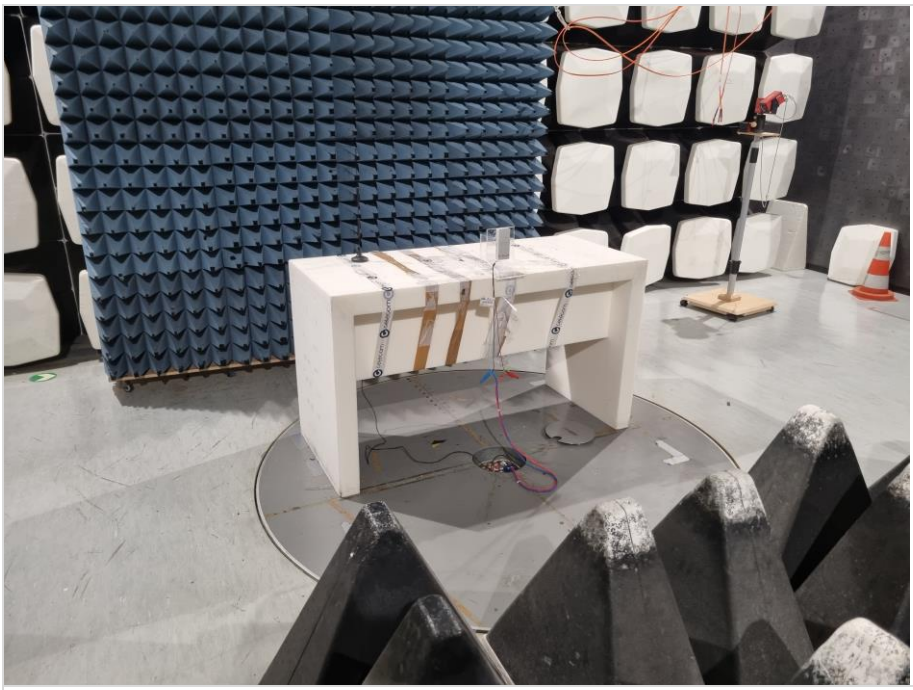
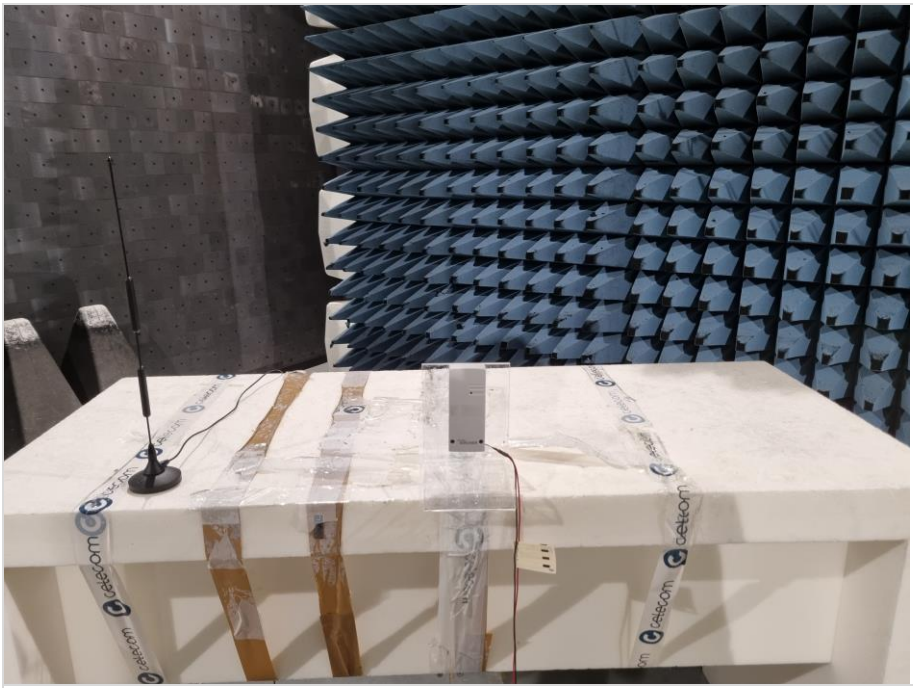
1 Test set up photographs (EUT/DUT)



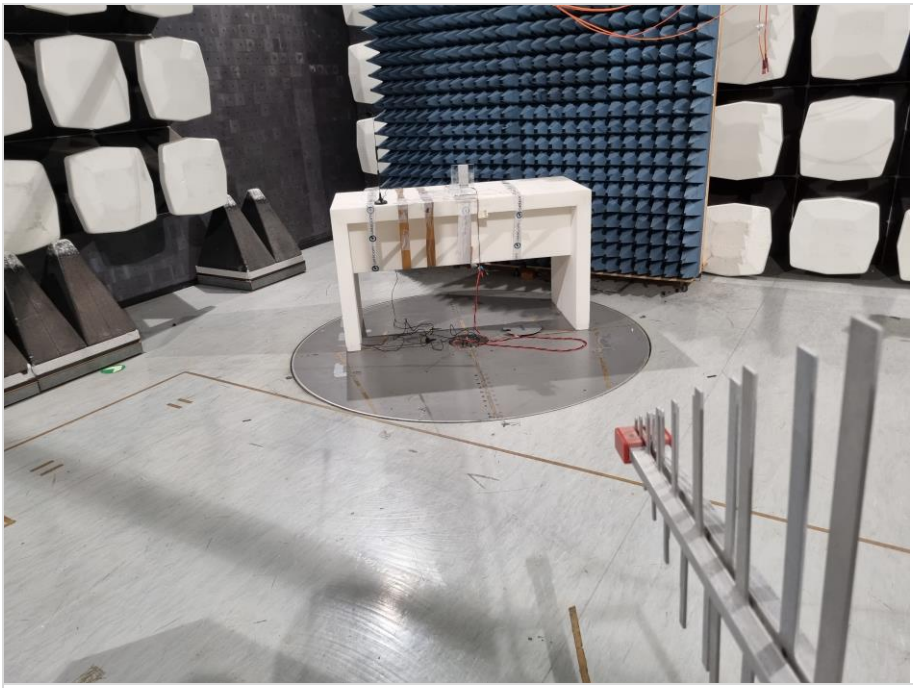
Photograph 1: EUT test setup in the semi anechoic chamber, measurement <30 MHz, overview



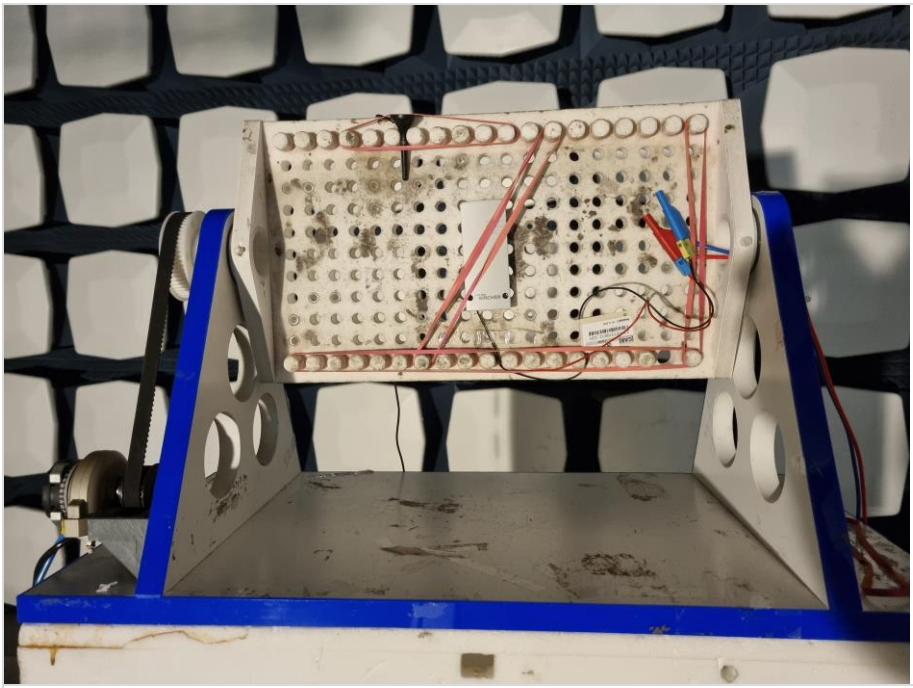
Photograph 2: EUT test setup in the semi anechoic chamber, measurement <30 MHz, close up view



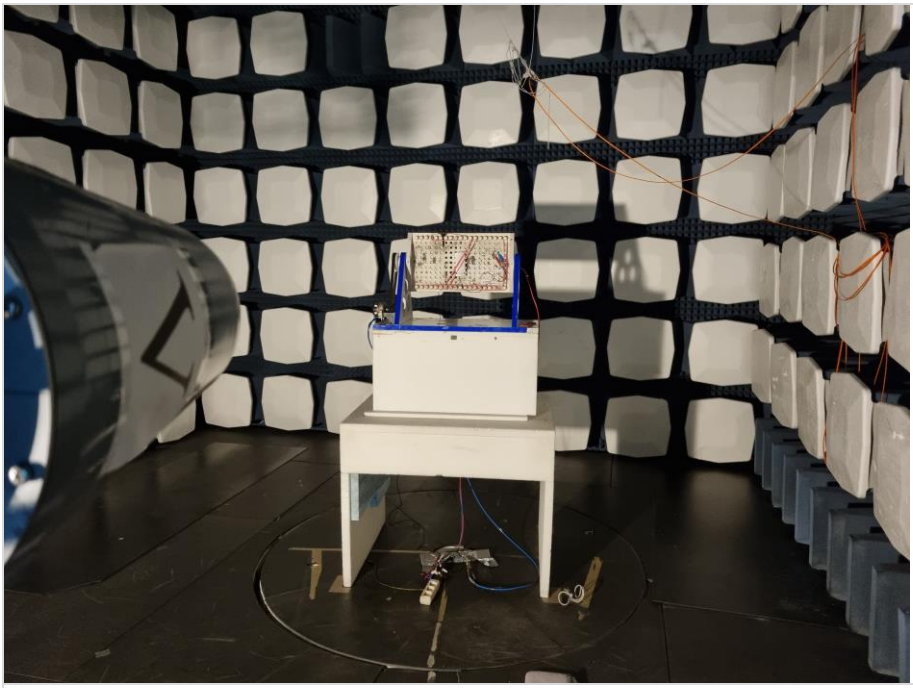
Photograph 3: EUT test setup in the semi anechoic chamber, measurement <1 GHz, close up view



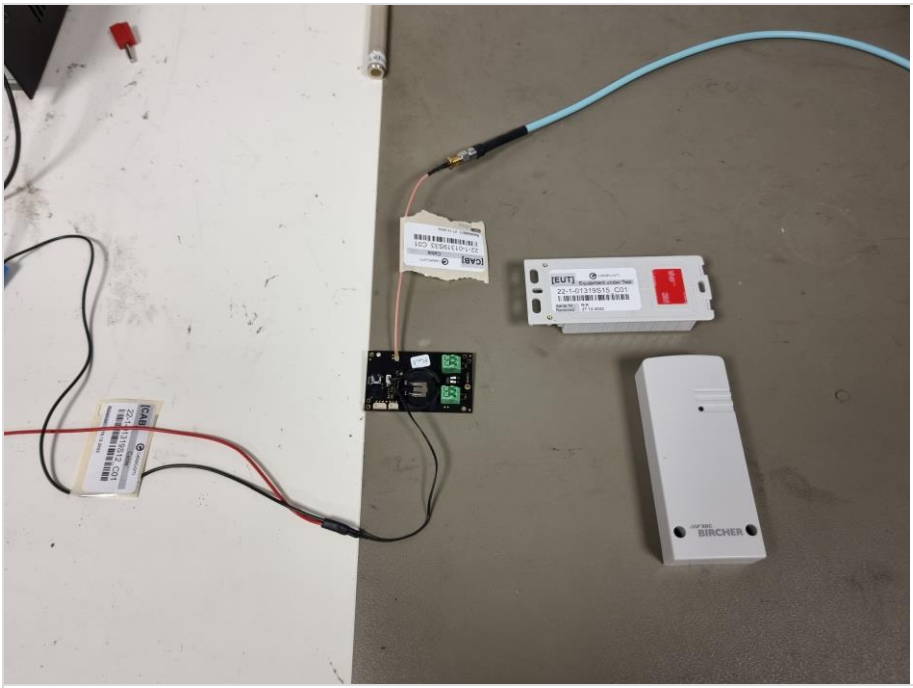
Photograph 4: EUT test setup in the semi anechoic chamber, measurement <1 GHz, overview



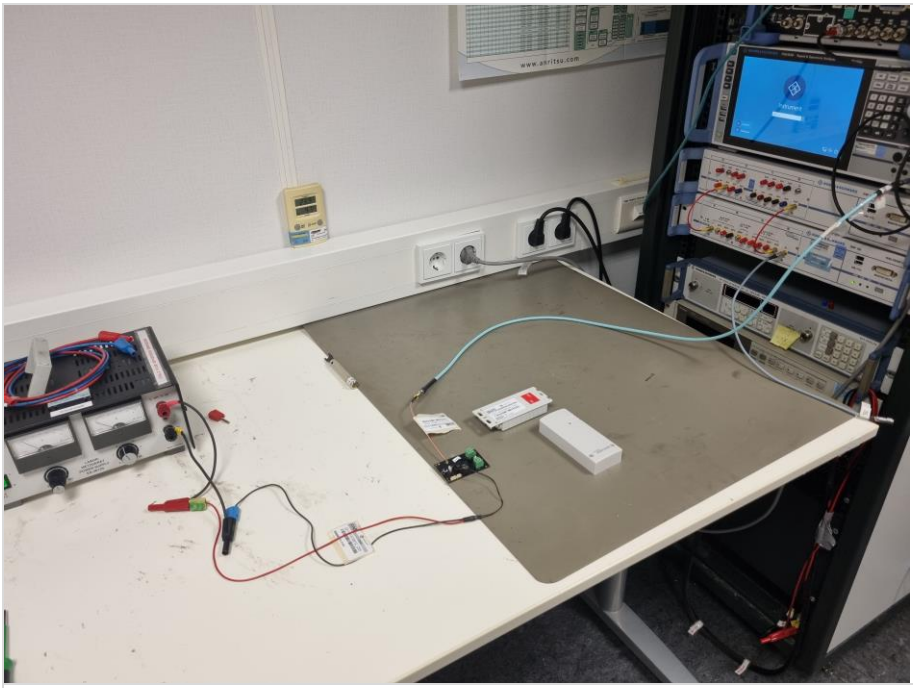
Photograph 5: EUT test setup in the fully anechoic chamber, measurement >1 GHz, close up view



Photograph 6: EUT test setup in the fully anechoic chamber, measurement >1 GHz, overview



Photograph 7: EUT test setup for conducted measurement, close up view



Photograph 8: EUT test setup for conducted measurement, overview

End Of Annex 4